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Chip Monolithic Ceramic Capacitor for General GRM21BR61A476ME15_ (0805, X5R:EIA, 47uF, DC10V)

_: packaging code

Reference Sheet

1.Scope

This product specification is applied to Chip Monolithic Ceramic Capacitor used for General Electronic equipment.

2.MURATA Part NO. System

(Ex.) GRM	21	В	R6	1A	476	М	E15	L
	(1)L/W Dimensions	(2)T Dimensions	(3)Temperature Characteristics	(4)Rated Voltage	(5)Nominal Capacitance	(6)Capacitance Tolerance	(7)Murata's Control Code	(8)Packaging Code

3. Type & Dimensions



(Unit:mm)

1

(1)-1 L	(1)-2 W	(2) T	е	g
2.0±0.2	1.25±0.2	1.25±0.2	0.2 to 0.7	0.7 min.

4.Rated value

Tillated Value						
\	e Characteristics ode):X5R(EIA)	(4) Rated	(5) Nominal	(6) Capacitance	Specifications and Test Methods	
Temp. coeff Temp. Range or Cap. Change (Ref.Temp.)		Voltage	Capacitance	Tolerance	(Operating Temp. Range)	
-15 to 15 %	-55 to 85 °C (25 °C)	DC 10 V	47 uF	±20 %	-55 to 85 °C	

5.Package

mark	(8) Packaging	Packaging Unit
L	φ180mm Reel EMBOSSED W8P4	3000 pcs./Reel
K	φ330mm Reel FMBOSSED W8P4	10000 pcs./Reel

Product specifications in this catalog are as of Mar.7,2016,and are subject to change or obsolescence without notice. Please consult the approval sheet before ordering.

Please read rating and !Cautions first.



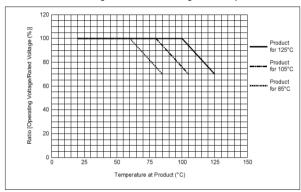
■ Specifications and Test Methods

$\overline{}$		2	Test Method				
No	Item	Specification	(Ref. Standard:JIS C 5101, IEC60384)				
1	Rated Voltage	Shown in Rated value.	The rated voltage is defined as the maximum voltage which may be				
			applied continuously to the capacitor.				
			When AC voltage is superimposed on DC voltage, V ^{P-P} or V ^{O-P} ,				
			whichever is larger, should be maintained within the rated voltage				
	A	No defeate or charges liking	range.				
3	Appearance	No defects or abnormalities.	Visual inspection.				
	Dimension Voltage proof	Within the specified dimensions. No defects or abnormalities.	Using calipers. (GRM02 size is based on Microscope) Measurement Point Between the terminations				
7	Vollage proof	130 GOLOGO OF ADHOTHICALLIES.	Test Voltage : 250% of the rated voltage				
			Applied Time :1 to 5 s				
			Charge/discharge current: 50mA max.				
5	Insulation Resistance(I.R.)	More than $50\Omega \cdot F$	Measurement Point : Between the terminations				
			Measurement Voltage : DC Rated Voltage				
			Charging Time 1 min				
			Charge/discharge current: 50mA max.				
			Measurement Temperature Room Temperature				
6	Capacitance Shown in Rated value.		Measurement Temperature Room Temperature				
7	Dissipation Factor (D.F.)	B1,R1,B3,R6,R7,C6,C7,C8,E7,D7: 0.1 max.	Capacitance Frequency Voltage				
,	υιοοιματίστι Γασίσι (υ.Γ.)	D8,GRM31CR60J107 : 0.15 max *Table 1	*1 C≦10µF (10V min.) 1.0+/-0.1kHz 1.0+/-0.2Vrms				
		GRM31CR71E106 : 0.125	*2 C < 10uE				
		GRM033 B3/R6 1A 104	(6.3V max.) 1.0+/-0.1kHz 0.5+/-0.1Vrms				
		GRM155 B3/R6 1A 124 to 105	C>10µF 120+/-24Hz 0.5+/-0.1Vrms				
		GRM185 B3/R6 1C/1A 105 GRM185 C8/D7 1A 105					
		GRM188 B3/R6 1C/1A 225	*1 For items listed in Table 1 on the left, the capacitance should				
		GRM188 R7/C8/D7 1A 225 GRM188 B3/R6 1A 335	be measured using a voltage of 0.5+/-0.1Vrms instead of				
		GRM219 B3/R6 1C/1A 475	1.0+/-0.2Vrms.				
		GRM219 C8 1A 475 GRM219 B3/R6 1A 106	*2 For item GRM188R70J105, the capacitance should be measured				
		GRM21B B3/R6 1C/1A 106	using a voltage of 1.0+/-0.2Vrms instead of 0.5+/-0.1Vrms.				
		GRM21B R7/C8 1A 106 GRM319 B3/R6 1C/1A 106					
8	Temperature No bias	B1,B3 : Within +/-10% (-25°C to +85°C)	The capacitance change should be measured after 5 min.				
O	Characteristics	R1,R7 : Within +/-15% (-25°C to +85°C)	at each specified temp. stage.				
	of Capacitance	R6 : Within +/-15% (-55°C to +85°C)	at each specified temp. stage. In case of applying voltage, the capacitance change should be measured after 1 min. with applying voltage in equilibration of each temp. stage.				
	- Spaniano	C6 : Within +/-22% (-55°C to +85°C)					
		C7 : Within+/-22% (-55°C to +125°C)					
		C8 : Within +/-22% (-55°C to +105°C)	Capacitance value as a reference is the value in step 3.				
		E7 : Within +22/-56% (-55°C to +125°C)					
		D7 : Within +22/-33% (-55°C to +125°C)	· Measurement Voltage: 0.15+/-0.03Vrms				
		D8 : Within +22/-33% (-55°C to +105°C)					
			Step Temperature(°C) Applying Voltage(VDC)				
	5001	D1. Within . 10/ 200/	1 Reference Temp. +/-2 2 Min. Operating Temp. +/-3				
	50% of	B1: Within +10/-30%	2 Min.Operating Temp. +/-3 3 Reference Temp. +/-2 No bias				
	the rated voltage	R1: Within +15/-40%	4 Max.Operating Temp. +/-3				
	voitage		5 Reference Temp. +/-2				
			6 Min.Operating Temp. +/-3 50% of				
			7 Reference Temp. +/-2 the rated voltage (For B1,R1)				
			8 Max.Operating Temp.+/-3				
			· Initial measurement				
			Perform a heat treatment at 150+0/-10°C for 1h and then				
			let sit for 24+/-2h at room temperature, then measure.				
	A II						
9	Adhesive Strength	No removal of the terminations or other defect	Solder the capacitor on the test substrate shown in Fig.3.				
	of Termination	should occur.	Type Applied Force(N)				
			GRM02 1				
			GRM03 2 GRM15/GRM18 5				
			GRM21/GRM31/GRM32 10				
			Holding Time : 10+/-1s				
			•				
			Applied Direction : In parallel with the test substrate and vertical with the capacitor side				
			capacitor side.				

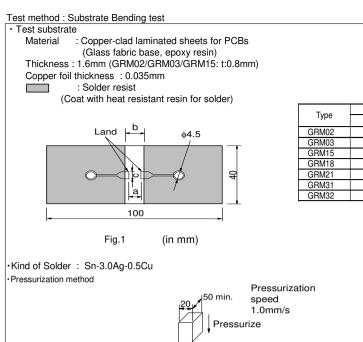
									murala
No	Iter	n	Specification			(Ref. Stand	Test Metho ard:JIS C 51		4)
10	Vibration	Appearance	No defects or abnormalities.	Sol	der the	capacitor on the te	est substrate	shown in Fig	1.3.
		Capacitance	Within the specified initial value.						
		D.F.	Within the specified initial value.	Kin	d of Vi		A simple harı 10Hz to 55Hz		
				Tot	al amp	litude	1.5mm		
				This	s motio	n should be applie	d for a period	of 2h in eac	h 3 mutually
				per	pendic	ular directions(total	l of 6h).		
11	Substrate	Appearance	No defects or abnormalities.	Sol	der the	capacitor on the te	est substrate	shown in Fig	j.1.
	Bending test	Capacitance	Within +/-10%	Pre	ssuriz	ation method :	Shown in Fig	.2	
		Change		Flex	kure	:	1mm		
				Hol	ding T	me .	5+/-1s		
				Sol	dering	Method :	Reflow solde	ring	
12	Solderability		95% of the terminations is to be soldered evenly and		t Meth		Solder bath n		
			continuously.	Flux			Solution of ro	-	
					heat		80°C to 120°C		30s
				Sol			Sn-3.0Ag-0.5	Cu	
					der Te	•	245+/-5°C		
40	D				nersio		2+/-0.5s		
13		Appearance	No defects or abnormalities.			size min.>	0.1.1		
	to Caldavian				t Meth		Solder bath n		
	Soldering			Sol			Sn-3.0Ag-0.5	Cu	
	Heat				der Te nersio	•	270+/-5°C 10+/-0.5s		
		Capacitance	Within +/-15%				10+/-0.58 24+/-2h		
		Capacitance	VVI((IIII +/-13 /6		osure heat			may : 120°C	to 150°C for 1 min
		Change		FIE	Heat		GRM32 size		to 120°C for 1 min
							CIT TIVIOZ SIZE		to 200°C for 1 min
					itial ma	asurement		and 170 C	10 200 C 101 1 111111
		D.F.	Within the specified initial value.				150±0/-10°C	for 1h and th	nen
		D.1 .	The opening initial value.	Perform a heat treatment at 150+0/-10°C for 1h and then let sit for 24+/-2h at room temperature, then measure.					
				<gl< td=""><td>RM02</td><td>size only></td><td></td><td></td><td></td></gl<>	RM02	size only>			
					t Meth	•	Reflow solde	ring (hot plat	e)
		I.R.	Within the specified initial value.	Sol			: Sn-3.0Ag-0.5Cu		
			'		der Te		270+/-5°C		
					low Ti	•	10+/-0.5s		
				Tes	t Subs	trate :	Glass epoxy	PCB	
		Voltage proof	No defects.	Exp	osure	Time :	24+/-2h		
				Pre	heat	: '	120°C to 150	°C for 1 min	
				· In	itial me	asurement			
				Per	form a	heat treatment at	150+0/-10°C	for 1h and th	nen
				let s	sit for 2	4+/-2h at room ten	nperature,the	n measure.	
14	Temperature	Appearance	No defects or abnormalities.	Sol	der the	capacitor on the te	est substrate	shown in Fig	1.3.
	Sudden Change					ne five cycles accor	rding to the fo	our heat trea	tments
				sho	wn in i	he following table.			
		Capacitance	B1,R1,B3,R6,R7,C6,C7,C8,D7,D8 : Within +/-7.5%		Step	Temp.(°C	C)	Time (min)	
		Change	E7 : Within +/-30%	1 +	1			30+/-3	
				1 -		Min.Operating Te			
		D.E.	Milabia aba a a a sifi ad iniai al calca		2	Room Ter	np	2 to 3	
		D.F.	Within the specified initial value.		3	Max.Operating Te	emp.+3/-0	30+/-3	
					4	Room Ter	mp	2 to 3	
		I.R.	Within the specified initial value.	Evr	osure	Timo	24+/-2h		
		i.n.	Within the specified initial value.	EXL	osure	Tille	24+/-211		
				. In	itial ma	asurement			
			No defects.				150±0/-10°C	for 1h and th	nen
		Voltage proof No de		Perform a heat treatment at 150+0/-10°C for 1h and then					
		Voltage proof			let sit for 24+/-2h at room temperature, then measure.				
		Voltage proof				B30J106M Measur	rement after t	est:	
		Voltage proof		· GI	RM188	B30J106M Measur heat treatment at			nen
		Voltage proof		· GF Per	RM188 form a		150+0/-10°C	for 1h and th	nen
15	High	Voltage proof Appearance	No defects or abnormalities.	· GI Per let s	RM188 form a sit for a	heat treatment at	150+0/-10°C nperature,the	for 1h and then measure.	
15	High Temperature			· GF Per let s Sol	RM188 form a sit for a der the	heat treatment at 4+/-2h at room ten capacitor on the te	150+0/-10°C nperature,the	for 1h and then measure.	
15	-			· GF Per let s Sole Tes	RM188 form a sit for a der the	heat treatment at 44+/-2h at room ten capacitor on the ten perature	150+0/-10°C mperature,the est substrate	for 1h and then measure.	
15	Temperature			· Gf Per let s Soli Tes	RM188 form a sit for a der the st Tem	heat treatment at 44+/-2h at room ten capacitor on the ten cerature : dity :: 1	150+0/-10°C nperature,the est substrate 40+/-2°C	for 1h and then measure.	
15	Temperature High	Appearance	No defects or abnormalities.	· GIPPer let s Soli Tes Tes	RM188 form a sit for a der the st Tem st Hum	heat treatment at 1/4+/-2h at room ten capacitor on the te perature : 4/4ty	150+0/-10°C nperature,the est substrate 40+/-2°C 90%RH to 95	for 1h and then measure. shown in Fig	
15	Temperature High Humidity	Appearance Capacitance	No defects or abnormalities.	· GIF Per let s Solu Tes Tes App	RM188 form a sit for a der the st Tem st Hum st Time blied V	heat treatment at 1/4+/-2h at room ten capacitor on the te perature : 4/4ty	150+0/-10°C nperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vo	for 1h and then measure. shown in Fig	
15	Temperature High Humidity	Appearance Capacitance	No defects or abnormalities.	· GIF Per let s Soli Tes Tes App Cha	RM188 form a sit for a der the st Tem st Hum st Time blied V	heat treatment at 14+/-2h at room ten capacitor on the ten cerature dity :: bltage :: chapter in the ten capacitor on the ten capacitor on the ten cerature :: chapter in the ten capacitor on the ten capacitor of the ten capacitor on the ten capacitor on the ten capacitor on the ten capacitor of the ten capacitor on the ten capacitor of the ten capacitor of ten capacitor on the ten capacitor on the ten capacitor of the ten capacitor of ten capacitor on the ten capacitor of ten capacit	150+0/-10°C nperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vo	for 1h and then measure. shown in Fig	
15	Temperature High Humidity	Appearance Capacitance Change	No defects or abnormalities. Within +/-12.5%	· GIF Per let s Soli Tes Tes App Cha	RM188 form a sit for 2 der the st Tem st Hum st Time t Time Varge/di	heat treatment at 14+/-2h at room ten capacitor on the ten cerature dity :: bltage :: chapter in the ten capacitor on the ten capacitor on the ten cerature :: chapter in the ten capacitor on the ten capacitor of the ten capacitor on the ten capacitor on the ten capacitor on the ten capacitor of the ten capacitor on the ten capacitor of the ten capacitor of ten capacitor on the ten capacitor on the ten capacitor of the ten capacitor of ten capacitor on the ten capacitor of ten capacit	150+0/-10°C nperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vc 50mA max.	for 1h and then measure. shown in Fig	
15	Temperature High Humidity	Appearance Capacitance Change	No defects or abnormalities. Within +/-12.5%	GIPER CHARLES CONTRACT CONTRAC	form a sit for a der the st Tem st Hum st Time blied V arge/di posure	heat treatment at 14+/-2h at room ten capacitor on the ten cerature dity :: bltage :: chapter in the ten capacitor on the ten capacitor on the ten cerature :: chapter in the ten capacitor on the ten capacitor of the ten capacitor on the ten capacitor on the ten capacitor on the ten capacitor of the ten capacitor on the ten capacitor of the ten capacitor of ten capacitor on the ten capacitor on the ten capacitor of the ten capacitor of ten capacitor on the ten capacitor of ten capacit	150+0/-10°C nperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vc 50mA max.	for 1h and then measure. shown in Fig	
15	Temperature High Humidity	Appearance Capacitance Change	No defects or abnormalities. Within +/-12.5%	GIPER SOLUTION TEST APPROVED CHARACTER SOLUTION TEST APPROVED CHAR	RM188 form a sit for 2 der the st Tem st Hum st Time to Time t	heat treatment at 14+/-2h at room ten capacitor on the ten cerature dity :: bltage :: charge current :: Time ::	150+0/-10°C mperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vc 50mA max. 24+/-2h	for 1h and then measure. shown in Fig %RH	J.3 .
15	Temperature High Humidity	Appearance Capacitance Change D.F.	No defects or abnormalities. Within +/-12.5% 0.2 max.	GIPER OF CHARLES OF CH	RM188 form a sit for 2 der the st Tem st Hum st Time blied V arge/diposure sitial me form a sit for 2	heat treatment at 14+/-2h at room ten capacitor on the capacitor on	150+0/-10°C mperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vc 50mA max. 24+/-2h	for 1h and then measure. shown in Fig %RH strage	J.3 .
15	Temperature High Humidity	Appearance Capacitance Change D.F.	No defects or abnormalities. Within +/-12.5% 0.2 max.	GIPER OF CHARLES OF CH	RM188 form a sit for a der the st Tem st Hum st Time blied V arge/diposure sitial me form a sit for a deasure	heat treatment at 14+/-2h at room ten capacitor on the capacitor of the capacitor on	150+0/-10°C mperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vc 50mA max. 24+/-2h 150+0/-10°C nperature,the	for 1h and then measure. shown in Fig. %RH shape for 1h and then measure.	j.3. nen
15	Temperature High Humidity	Appearance Capacitance Change D.F.	No defects or abnormalities. Within +/-12.5% 0.2 max.	GIPER PER PER PER PER PER PER PER PER PER	RM188 form a a sit for a der the st Tem st Hum st Time	heat treatment at 14+/-2h at room ten capacitor on the capacitor on	150+0/-10°C mperature,the est substrate 40+/-2°C 90%RH to 95 500+/-12h DC Rated Vc 50mA max. 24+/-2h 150+0/-10°C nperature,the	for 1h and then measure. shown in Fig. %RH shape for 1h and then measure. for 1h and then measure.	j.3. nen

No	Item		Specification	Test Method (Ref. Standard:JIS C 5101, IEC60384)		
16	Durability Appearance		Durability Appearance No defects or abnormalities.		No defects or abnormalities.	Solder the capacitor on the test substrate shown in Fig.3.
				Test Temperature : Max. Operating Temp. +/-3°C		
		Capacitance	Within +/-12.5%	Test Time : 1000+/-12h		
		Change		Applied Voltage : 100% of the rated voltage		
				Charge/discharge current: 50mA max.		
				Exposure Time : 24+/-2h		
		D.F.	0.2 max.			
				· Initial measurement		
				Perform a heat treatment at 150+0/-10°C for 1h and then		
				let sit for 24+/-2h at room temperature, then measure.		
		I.R.	More than 12.5Ω · F	· Measurement after test		
				Perform a heat treatment at 150+0/-10°C for 1h and then		
				let sit for 24+/-2h at room temperature, then measure.		

Recommended derating conditions on voltage and temperature

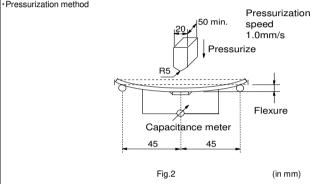


These Part Numbers are designed for use in the circuits where continuous applied voltage to the capacitor is derated than rated voltage, and guarantee Durability Test with 100% \times rated voltage as testing voltage at the maximum operating temperature. The voltage and temperature derating conditions on the left are recommended for use to ensure the same reliability level as normal specification.



Dimension (mm) 0.2 *0.56 0:23 0.3 0,9.5 1.5 3.0 0.3 0.4 1.0 12 1.2 4.0 1.65 5.0

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Adhesive Strength of Termination, Vibration, Temperature Sudden Change, Resistance to Soldering Heat (Reflow method)

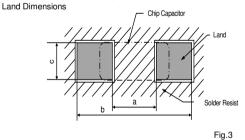
High Temperature High Humidity(Steady), Durability

 Test substrate Copper-clad laminated sheets for PCBs Material

(Glass fabric base, epoxy resin)

Thickness: 1.6mm or 0.8mm Copper foil thickness : 0.035mm

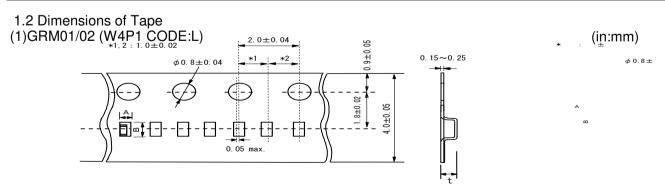
Kind of Solder: Sn-3.0Ag-0.5Cu



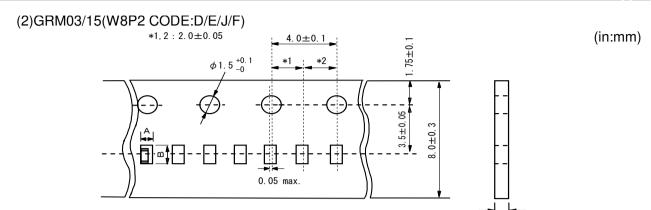
Tuno		Dimension (mm)	
Туре	а	b	С
GRM02	0.2	0.56	0.23
GRM03	0.3	0.9	0.3
GRM15	0.4	1.5	0.5
GRM18	1.0	3.0	1.2
GRM21	1.2	4.0	1.65
GRM31	2.2	5.0	2.0
GRM32	2.2	5.0	2.9

1.Tape Carrier Packaging(Packaging Code:D/E/W/L/J/F/K) 1.1 Minimum Quantity(pcs./reel)

1.1 Min	imum Quantity(pcs./reel)					
			φ180mm reel	φ330mm reel		
	Type	Pape	r Tape	Plastic Tape	Paper Tape	Plastic Tape
		Code:D/E	Code:W	Code:L	Code:J/ F	Code:K
GRM01				50000(W4P1)		
GRM02				40000(W4P1)	$\ $	$\ $
	2	15000(W8P2)			50000(W8P2)	
GRM03	3	15000(W8P2)	30000(W8P1)		50000(W8P2)	
	5	10000(W8P2)			50000(W8P2)	
	2	20000(W8P2)			50000(W8P2)	
	3/X	10000(W8P2)			50000(W8P2)	
	5(LWT Dimensions Tolerance:±0.05)	10000(W8P2)	20000(W8P1)		50000(W8P2)	
GRM15	5(LWT Dimensions Tolerance:±0.1min.)	10000(W8P2)			40000(W8P2)	
GI IIVI TO	5 (LW Dimensions Tolerance:±0.1min. and T Dimensions Tolerance:±0.05)	10000(W8P2)			50000(W8P2)	
	5(LW Dimensions Tolerance:±0.2 and T Dimensions:0.5 +0/-0.1)	10000(W8P2)				
GRM18	-	4000		$\bigg \bigg $	10000	$\bigg \bigg $
	6	4000			10000	
GRM21	9	4000		3000	10000	10000
	A/B			3000		10000
	6/9	4000			10000	
GRM31	M/X			3000		10000
	С			2000		6000
	9	4000			10000	
	A/M			3000		10000
GRM32	N			2000		8000
	С			2000		6000
	R/D/E			1000		4000
	М			1000		5000
GRM43	N/R/D			1000		4000
GI IIVI-10	E			500		2000
	S			500		1500
	М			1000		5000
GRM55	N/C/R/D			1000		4000
	E			500		
	F			300		1500



Туре		D	imensions(Chi	p)	A *3 B *3		+	
Type		L	W	Т	Α 3	ЬЗ	ι	
GRM01	1	0.25±0.013	0.125±0.013	0.125±0.013	0.145	0.27	0.4 max.	
GRM02	2	0.4±0.02	0.2±0.02	0.2±0.02	0.23	0.43	0.5 max.	
GRIVIUZ	_	0.4±0.05	0.2±0.05	0.2±0.05	0.26	0.46	U.S IIIdx.	

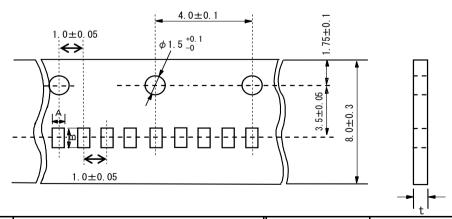


Type]	Dimensions(Ch	ip)	A *3	B *3	+	
Туре		L W T		Т	A 3	Вδ	ι	
	2	0.6±0.03	0.3±0.03	0.2 +0.02/-0.04	0.37	0.67		
		0.0±0.03	0.5±0.05	0.3±0.03	0.57	0.07	0.5 max.	
GRM03	3	0.6±0.05	0.3±0.05	0.3±0.05	0.39	0.69		
		0.6±0.09	0.3±0.09	0.3±0.09	0.44	0.74	0.6 max.	
	5	0.0±0.03	0.5±0.09	0.5±0.05	0.44	0.74		
	2			0.2 +0.02/-0.04				
	Χ		0.25±0.05	0.65	1.15			
	3			0.3±0.03				
	כ	1.0±0.2	0.5±0.2		0.78	1.29		
		1.0±0.05	0.5±0.05	0.5±0.05	0.65	1.15	0.8 max.	
GRM15		1.0±0.07	0.5±0.07	0.5±0.07	0.03	1.13	0.0 max.	
		1.0±0.1	0.5±0.1	0.5±0.1	0.70	1.20		
	5	1.0±0.15	0.5±0.15	0.5±0.15	0.72	1.25		
			0.5 +0/-0.1					
		1.0±0.2	1.0±0.2 0.5±0.2	0.5±0.2	0.78	1.29		
				0.5±0.05				

^{*3} Nominal value

(3)GRM033/155(W8P1 CODE:W)

(in:mm)



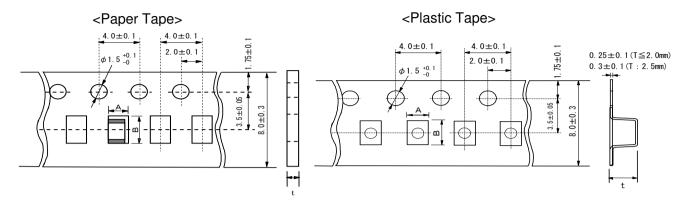
Туре		Dimensions(Chip)		A *3	B *3	+	
	,	L	W	Т	Α 3	В 3	ı
		0.6±0.03	0.3±0.03	0.3±0.03	0.37	0.67	0.5 max.
GRM03	3	0.6±0.05	0.3±0.05	0.3±0.05	0.39	0.69	0.5 max.
		0.6±0.09	0.3±0.09	0.3±0.09	0.44	0.74	0.6 max.
GRM15	5	1.0±0.05	0.5±0.05	0.5±0.05	0.65	1.15	0.8 max.

^{*3} Nominal value

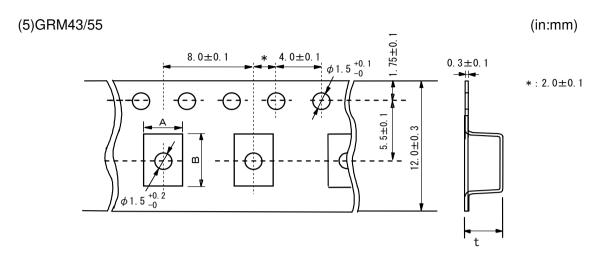
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Package GRM Type

(4)GRM18/21/31/32 (in:mm)



		Dimensions(Chip)		_	_	_	Dimensions	
Туре	9	L	W	Т	А	В	t	of Tape
		1.6±0.1	0.8±0.1	0.5 +0/-0.1	1.05±0.10	1.85±0.10		
	5	1.6±0.2	0.8±0.2	0.5±0.05	1.10±0.10	2.00±0.10	0.8 max.	
GRM18	6 7			0.6 +0/-0.1 0.7±0.1				
		1.6±0.1	0.8±0.1	0.8±0.1				
	8	1.6±0.15	0.8±0.15	0.8±0.15	1.05±0.10	1.85±0.10		
		1.6±0.2	0.8±0.2	0.8±0.2	1.10±0.10	2.00±0.10		D T
				0.6±0.1				Paper Tape
	6			0.6 +0/-0.15			1.15	
		2.0±0.1	1.25±0.1	0.85±0.05			1.15 max.	
		2.0±0.1	1.20±0.1	0.85±0.1	1.55±0.15	2.30±0.15		
				0.85 +0.15/-0.1	1.55±0.15	2.30±0.13		
	9			0.85 +0/-0.2				
GRM21		2.0±0.15	1.25±0.15	0.85±0.1				
T CIT IIVIZ I		2.0±0.2	1.25±0.2	0.00±0.1				
		2.010.2		0.85 +0.15/-0.05	1.50±0.20	2.30±0.20]	
	A	2.0±0.1	1.25±0.1	1.0 +0/-0.2	1.45±0.20	2.25±0.20	1.7 max.	Plastic Tape
		2.0±0.2	1.25±0.2	1.0±0.2	1.50±0.20	2.30±0.20		
	В	2.0±0.1	1.25±0.1	1.25±0.1	1.45±0.20	2.25±0.20	2.0 max.	
		2.0±0.15	1.25±0.15	1.25±0.15	1.50±0.20	2.30±0.20		
		2.0±0.2	1.25±0.2	1.25±0.2	1.0020.20	2.00_0.20		
	6	3.2±0.15 1.6±0.15		0.6±0.1				
	9	3.2±0.2	1.6±0.2	0.85±0.1	2.00±0.20	3.60±0.20	1.15 max.	Paper Tape
	В	3.2±0.2	1.0±0.2	1.25±0.1				
GRM31	Ь	3.2±0.15	1.6±0.15	1.25±0.1 1.15±0.1				
Griivis	М			1.15±0.15	1.90±0.20	3.50±0.20	1.7 max.	
	Х	3.2±0.2	1.6±0.2	1.2±0.1	1.00±0.20	0.00±0.20		Plastic Tape
		0.2_0.2	1.0_0.2	1.6±0.2				
	С	3.2±0.3	1.6±0.3	1.6±0.3	2.10±0.20	3.60±0.20	2.5 max.	
	9			0.85 +0.15/-0.05	2.80±0.20	3.60±0.20	1.15 max.	Paper Tape
	Α			1.0 +0/-0.2				-4
	М			1.15±0.1			1.7 max.	
00,400	N	0.0:0.0	0.5:0.0	1.35±0.15				
GRM32		3.2±0.3	2.5±0.2	1.6±0.2	2.80±0.20	3.50±0.20	2.5 max.	Plastic Tape
	R			1.8±0.2			2.0 may	†
	D			2.0±0.2			3.0 max.	
	Ε			2.5±0.2			3.7 max.	



Type		Dimensions(Chip)			A *1	B *1	+
Туре		L	W	Т	AI	ы	ι
	М			1.15±0.1			
	Ν			1.35±0.15		4.9	2.5 max.
GRM43	R	4.5±0.4	3.2±0.3	1.8±0.2	3.6		
GRIVI43	D	4.5±0.4		2.0±0.2	3.0		3.7 max.
	Е]		2.5±0.2			J.7 IIIax.
	S			2.8±0.2			4.7 max.
	М			1.15±0.1			
	Ν	5.7±0.4 5.0±0.4).4 5.0±0.4	1.35±0.15	5.2	6.1	2.5 max.
	С			1.6±0.2			2.5 IIIax.
GRM55	R			1.8±0.2			
	D		2.0±0.2			3.7 max.	
	Е			2.5±0.2			o.i illax.
	F			3.2±0.2			4.7 max.

^{*1} Nominal value

単位:

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Fig.1 Package Chips (in:mm) Chip

Dimensions of Reel Fig.2

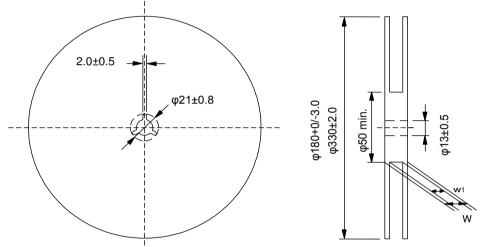
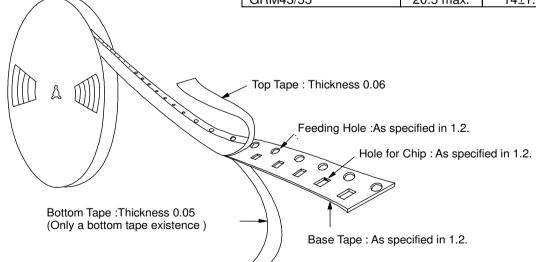


Fig.3 Taping Diagram

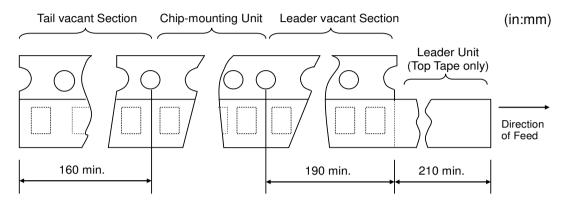
	W	W ₁
GRM01/02	8.0 max.	5±1.5
GRM03/15/18/21/31/32	16.5 max.	10±1.5
GRM43/55	20.5 max.	14±1.5



チップ詰め状態

単位:

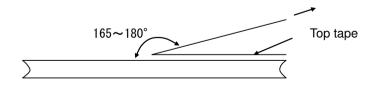
- 1.3 Tapes for capacitors are wound clockwise shown in Fig.3. (The sprocket holes are to the right as the tape is pulled toward the user.)
- 1.4 Part of the leader and part of the vacant section are attached as follows.



- 1.5 Accumulate pitch : 10 of sprocket holes pitch = 20±0.3mm(GRM01/02) 40±0.3mm(GRM03 min.)
- 1.6 Chip in the tape is enclosed by top tape and bottom tape as shown in Fig.1.
- 1.7 The top tape and base tape are not attached at the end of the tape for a minimum of 5 pitches.
- 1.8 There are no jointing for top tape and bottom tape.
- 1.9 There are no fuzz in the cavity.
- 1.10 Break down force of top tape : 5N min.

 Break down force of bottom tape : 5N min. (Only a bottom tape existence)
- 図 チップ詰め取慮 is made by resin and appeaser and dimeps極n is shown in Fig 2.

 There are possibly to change the material and dimension due to some impairment.
 - 1.12 Peeling off force: 0.1N to 0.6N* in the direction as shown below.
 - * GRM01/02/03:0.05N~0.5N



1.13 Label that show the customer parts number, our parts number, our company name, inspection number and quantity, will be put in outside of reel.

■Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment (2) Aerospace equipment (3) Undersea equipment (4) Power plant control equipment
- ⑤Medical equipment ⑥Transportation equipment(vehicles,trains,ships,etc.) ⑦Traffic signal equipment
- ®Disaster prevention / crime prevention equipment
 9Data-processing equipment
- (1) Application of similar complexity and/or reliability requirements to the applications listed in the above.

■Storage and Operation condition

- 1. The performance of chip monolithic ceramic capacitors may be affected by the storage conditions.
- 1-1. Store the capacitors in the following conditions:

Room Temperature of +5°C to +40°C and a Relative Humidity of 20% to 70%.

- (1) Sunlight, dust, rapid temperature changes, corrosive gas atmosphere, or high temperature and humidity conditions during storage may affect solderability and packaging performance.
 - Therefore, please maintain the storage temperature and humidity. Use the product within six months, as prolonged storage may cause oxidation of the terminations (outer electrodes).
- (2) Please confirm solderability before using after six months.
 - Store the capacitors without opening the original bag.

Even if the storage period is short, do not exceed the specified atmospheric conditions.

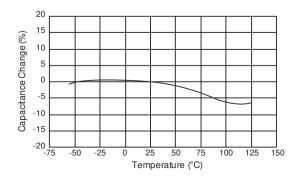
- 1-2. Corrosive gas can react with the termination (external) electrodes or lead wires of capacitors, and result in poor solderability. Do not store the capacitors in an atmosphere consisting of corrosive gas (e.g.,hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.).
- 1-3. Due to moisture condensation caused by rapid humidity changes, or the photochemical change caused by direct sunlight on the terminal electrodes and/or the resin/epoxy coatings, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or in high huimidity conditions

■ Rating

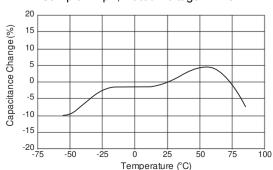
1.Temperature Dependent Characteristics

- 1. The electrical characteristics of the capacitor can change with temperature.
- 1-1. For capacitors having larger temperature dependency, the capacitance may change with temperature changes. The following actions are recommended in order to ensure suitable capacitance values.
 - (1) Select a suitable capacitance for the operating temperature range.
 - (2) The capacitance may change within the rated temperature. When you use a high dielectric constant type capacitor in a circuit that needs a tight (narrow) capacitance tolerance (e.g., a time-constant circuit), please carefully consider the temperature characteristics, and carefully confirm the various characteristics in actual use conditions and the actual system.

[Example of Temperature Caracteristics X7R(R7)] Sample: 0.1µF, Rated Voltage 50VDC



[Example of Temperature Characteristics X5R(R6)] Sample: 22µF, Rated Voltage 4VDC

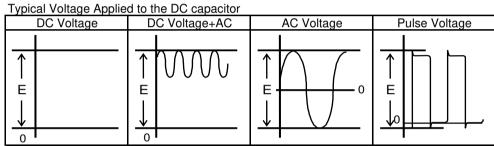


2.Measurement of Capacitance

- 1. Measure capacitance with the voltage and frequency specified in the product specifications.
- 1-1. The output voltage of the measuring equipment may decrease occasionally when capacitance is high. Please confirm whether a prescribed measured voltage is impressed to the capacitor.
- 1-2. The capacitance values of high dielectric constant type capacitors change depending on the AC voltage applied. Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

3. Applied Voltage

- 1. Do not apply a voltage to the capacitor that exceeds the rated voltage as called out in the specifications.
- 1-1. Applied voltage between the terminals of a capacitor shall be less than or equal to the rated voltage.
 - (1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated DC voltage. When AC voltage or pulse voltage is applied, the peak-to-peak voltage shall not exceed the rated DC voltage.
 - (2) Abnormal voltages (surge voltage, static electricity, pulse voltage, etc.) shall not exceed the rated DC voltage.



(E : Maximum possible applied voltage.)

1-2. Influence of over voltage

Over voltage that is applied to the capacitor may result in an electrical short circuit caused by the breakdown of the internal dielectric layers.

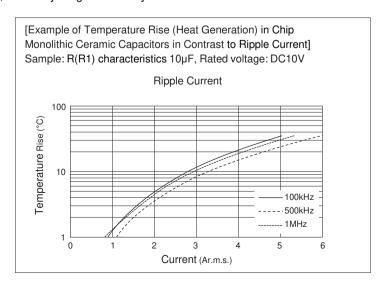
The time duration until breakdown depends on the applied voltage and the ambient temperature.

4. Type of Applied Voltage and Self-heating Temperature

- 1. Confirm the operating conditions to make sure that no large current is flowing into the capacitor due to the continuous application of an AC voltage or pulse voltage.
 - When a DC rated voltage product is used in an AC voltage circuit or a pulse voltage circuit, the AC current or pulse current will flow into the capacitor; therefore check the self-heating condition.
 - Please confirm the surface temperature of the capacitor so that the temperature remains within the upper limits of the operating temperature, including the rise in temperature due to self-heating. When the capacitor is used with a high-frequency voltage or pulse voltage, heat may be generated by dielectric loss.

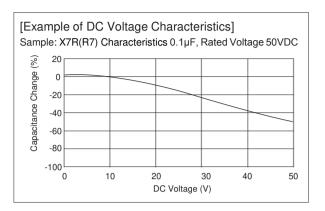
<Applicable to Rated Voltage of less than 100VDC>

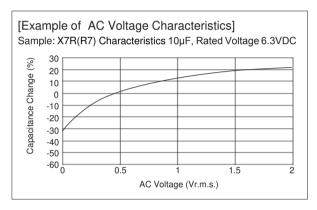
1-1. The load should be contained to the level such that when measuring at atmospheric temperature of 25°C, the product's self-heating remains below 20°C and the surface temperature of the capacitor in the actual circuit remains within the maximum operating temperature.



5. DC Voltage and AC Voltage Characteristic

- The capacitance value of a high dielectric constant type capacitor changes depending on the DC voltage applied. Please consider the DC voltage characteristics when a capacitor is selected for use in a DC circuit.
- 1-1. The capacitance of ceramic capacitors may change sharply depending on the applied voltage. (See figure) Please confirm the following in order to secure the capacitance.
- (1) Determine whether the capacitance change caused by the applied voltage is within the allowed range.
- (2) In the DC voltage characteristics, the rate of capacitance change becomes larger as voltage increases, even if the applied voltage is below the rated voltage. When a high dielectric constant type capacitor is used in a circuit that requires a tight (narrow) capacitance tolerance (e.g., a time constant circuit), please carefully consider the voltage characteristics, and confirm the various characteristics in the actual operating conditions of the system.
- The capacitance values of high dielectric constant type capacitors changes depending on the AC voltage applied.
 Please consider the AC voltage characteristics when selecting a capacitor to be used in a AC circuit.

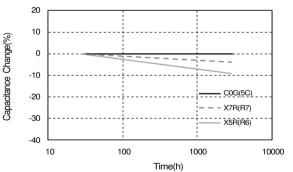




6. Capacitance Aging

The high dielectric constant type capacitors
have an Aging characteristic in which the capacitance
value decreases with the passage of time.
When you use a high dielectric constant type
capacitors in a circuit that needs a tight (narrow)
capacitance tolerance (e.g., a time-constant circuit),
please carefully consider the characteristics
of these capacitors, such as their aging, voltage,
and temperature characteristics. In addition,
check capacitors using your actual appliances
at the intended environment and operating conditions.

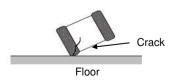
[Example of Change Over Time (Aging characteristics)]

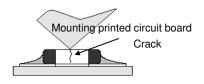


7.Vibration and Shock

- 1. Please confirm the kind of vibration and/or shock, its condition, and any generation of resonance.

 Please mount the capacitor so as not to generate resonance, and do not allow any impact on the terminals.
- Mechanical shock due to being dropped may cause damage or a crack in the dielectric material of the capacitor.
 Do not use a dropped capacitor because the quality and reliability may be deteriorated.
- 3. When printed circuit boards are piled up or handled, the corner of another printed circuit board should not be allowed to hit the capacitor in order to avoid a crack or other damage to the capacitor.



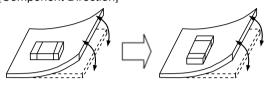


■Soldering and Mounting

1.Mounting Position

- 1. Confirm the best mounting position and direction that minimizes the stress imposed on the capacitor during flexing or bending the printed circuit board.
- 1-1.Choose a mounting position that minimizes the stress imposed on the chip during flexing or bending of the board.

 [Component Direction]



Locate chip horizontal to the direction in which stress acts.

(Bad Example)

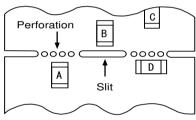
(Good Example)

[Chip Mounting Close to Board Separation Point]

It is effective to implement the following measures, to reduce stress in separating the board.

It is best to implement all of the following three measures; however, implement as many measures as possible to reduce stress.

Contents of Measures	Stress Level
(1) Turn the mounting direction of the component parallel to the board separation surface.	A > D*1
(2) Add slits in the board separation part.	A > B
(3) Keep the mounting position of the component away from the board separation surface.	A > C

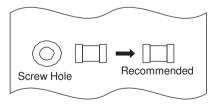


*1 A > D is valid when stress is added vertically to the perforation as with Hand Separation. If a Cutting Disc is used, stress will be diagonal to the PCB, therefore A > D is invalid.



[Mounting Capacitors Near Screw Holes]

When a capacitor is mounted near a screw hole, it may be affected by the board deflection that occurs during the tightening of the screw. Mount the capacitor in a position as far away from the screw holes as possible.



2.Information before Mounting

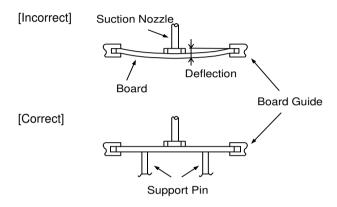
- 1. Do not re-use capacitors that were removed from the equipment.
- 2. Confirm capacitance characteristics under actual applied voltage.
- 3. Confirm the mechanical stress under actual process and equipment use.
- 4. Confirm the rated capacitance, rated voltage and other electrical characteristics before assembly.
- 5. Prior to use, confirm the solderability of capacitors that were in long-term storage.
- 6. Prior to measuring capacitance, carry out a heat treatment for capacitors that were in long-term storage.
- 7. The use of Sn-Zn based solder will deteriorate the reliability of the MLCC.

 Please contact our sales representative or product engineers on the use of Sn-Zn based solder in advance.



3. Maintenance of the Mounting (pick and place) Machine

- 1. Make sure that the following excessive forces are not applied to the capacitors.
- 1-1. In mounting the capacitors on the printed circuit board, any bending force against them shall be kept to a minimum to prevent them from any damage or cracking. Please take into account the following precautions and recommendations for use in your process.
 - (1) Adjust the lowest position of the pickup nozzle so as not to bend the printed circuit board.
 - (2) Adjust the nozzle pressure within a static load of 1N to 3N during mounting.

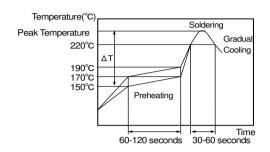


2. Dirt particles and dust accumulated between the suction nozzle and the cylinder inner wall prevent the nozzle from moving smoothly. This imposes greater force upon the chip during mounting, causing cracked chips. Also, the locating claw, when worn out, imposes uneven forces on the chip when positioning, causing cracked chips. The suction nozzle and the locating claw must be maintained, checked and replaced periodically.

4-1.Reflow Soldering

- When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both the components and the PCB.
 Preheating conditions are shown in table 1. It is required to keep the temperature differential between the solder and the components surface (ΔT) as small as possible.
- Solderability of tin plating termination chips might be deteriorated when a low temperature soldering profile where the peak solder temperature is below the melting point of tin is used. Please confirm the solderability of tin plated termination chips before use.
- 3. When components are immersed in solvent after mounting, be sure to maintain the temperature difference (ΔT) between the component and the solvent within the range shown in the table 1.

[Standard Conditions for Reflow Soldering]



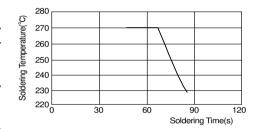
[Allowable Reflow Soldering Temperature and Time]

 Table 1

 Series
 Chip Dimension(L/W)
 Code Temperature Differential

 GRM
 01/02/03/15/18/21/31
 Δ T ≤ 190°C

 GRM
 32/43/55
 Δ T ≤ 130°C



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.

Recommended	Conditions
necommended	COHUILIONS

	Lead Free Solder
Peak Temperature	240 to 260°C
Atmosphere	Air or N ₂

Lead Free Solder: Sn-3.0Ag-0.5Cu

- 4. Optimum Solder Amount for Reflow Soldering
- 4-1. Overly thick application of solder paste results in a excessive solder fillet height.

 This makes the chip more susceptible to mechanical and thermal stress on the board and may cause the chips to crack.
- 4-2. Too little solder paste results in a lack of adhesive strength on the termination, which may result in chips breaking loose from the PCB.
- 4-3. Please confirm that solder has been applied smoothly to the termination.

Inverting	the	PCB	

Make sure not to impose any abnormal mechanical shocks to the PCB.

4-2.Flow Soldering

1. Do not apply flow soldering to chips not listed in Table 2.

Table 2

Series	Chip Dimension(L/W) Code	Temperature Differential
GRM	18/21/31	ΔT≦150°C

- 2. When sudden heat is applied to the components, the mechanical strength of the components will decrease because a sudden temperature change causes deformation inside the components. In order to prevent mechanical damage to the components, preheating is required for both of the components and the PCB. Preheating conditions are shown in table 2. It is required to keep the temperature differential between the solder and the components surface (ΔT) as low as possible.
- 3. Excessively long soldering time or high soldering temperature can result in leaching of the terminations, causing poor adhesion or a reduction in capacitance value due to loss of contact between the inner electrodes and terminations.
- 4. When components are immersed in solvent after mounting, be sure to maintain the temperature differential (ΔT) between the component and solvent within the range shown in the table 2.

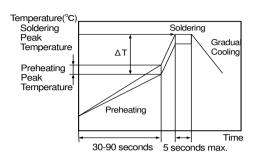
Recommended Conditions

Lead Free Solder
100 to 120℃
250 to 260°C
Air or N ₂

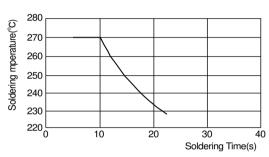
Lead Free Solder: Sn-3.0Ag-0.5Cu

- 5. Optimum Solder Amount for Flow Soldering
- 5-1. The top of the solder fillet should be lower than the thickness of the components. If the solder amount is excessive, the risk of cracking is higher during board bending or any other stressful condition.

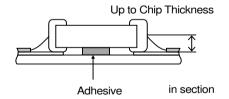
[Standard Conditions for Flow Soldering]



[Allowable Flow Soldering Temperature and Time]



In the case of repeated soldering, the accumulated soldering time must be within the range shown above.



4-3. Correction of Soldered Portion

When sudden heat is applied to the capacitor, distortion caused by the large temperature difference occurs internally, and can be the cause of cracks. Capacitors also tend to be affected by mechanical and thermal stress depending on the board preheating temperature or the soldering fillet shape, and can be the cause of cracks. Please refer to "1. PCB Design" or "3. Optimum solder amount" for the solder amount and the fillet shapes.

- 1. Correction with a Soldering Iron
 - 1-1. In order to reduce damage to the capacitor, be sure to preheat the capacitor and the mounting board.

 Preheat to the temperature range shown in Table 3. A hot plate, hot air type preheater, etc. can be used for preheating.
- 1-2. After soldering, do not allow the component/PCB to cool down rapidly.
- 1-3. Perform the corrections with a soldering iron as quickly as possible. If the soldering iron is applied too long, there is a possibility of causing solder leaching on the terminal electrodes, which will cause deterioration of the adhesive strength and other problems.

Table 3

Series	Chip Dimension (L/W) Code	Temperature of Soldering Iron Tip	Preheating Temperature	Temperature Differential(ΔT)	Atmosphere
GRM	03/15/18/21/31	350°C max.	150°C min.	ΔT≦190°C	Air
GRM	32/43/55	280°C max.	150°C min.	ΔT≦130°C	Air

Lead Free Solder: Sn-3.0Ag-0.5Cu

2. Correction with Spot Heater

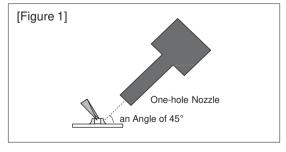
Compared to local heating with a soldering iron, hot air heating by a spot heater heats the overall component and board, therefore, it tends to lessen the thermal shock. In the case of a high density mounted board, a spot heater can also prevent concerns of the soldering iron making direct contact with the component.

- 2-1. If the distance from the hot air outlet of the spot heater to the component is too close, cracks may occur due to thermal shock. To prevent this problem, follow the conditions shown in Table 4.
- 2-2. In order to create an appropriate solder fillet shape, it is recommended that hot air be applied at the angle shown in Figure 1.

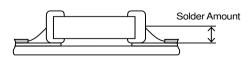
Table 4

Distance	5mm or more
Hot Air Application angle	45° *Figure 1
Hot Air Temperature Nozzle Outlet	400°C max.
	Less than 10 seconds
Application Time	(3216M / 1206 size or smaller)
	Less than 30 seconds
	(3225M / 1210 size or larger)

(3216M, 3225M: Metric size code)



- 3. Optimum solder amount when re-working with a soldering iron
- 3-1. If the solder amount is excessive, the risk of cracking is higher during board bending or any other stressful condition. Too little solder amount results in a lack of adhesive strength on the termination, which may result in chips breaking loose from the PCB.
 - Please confirm that solder has been applied smoothly is and rising to the end surface of the chip.
- 3-2. A soldering iron with a tip of ø3mm or smaller should be used. It is also necessary to keep the soldering iron from touching the components during the re-work.
- 3-3. Solder wire with Ø0.5mm or smaller is required for soldering.



in section

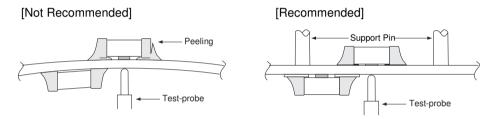
^{*} Please manage Δ T in the temperature of soldering iron and the preheating temperature.

5.Washing

Excessive ultrasonic oscillation during cleaning can cause the PCBs to resonate, resulting in cracked chips or broken solder joints. Take note not to vibrate PCBs.

6.Electrical Test on Printed Circuit Board

- 1. Confirm position of the support pin or specific jig, when inspecting the electrical performance of a capacitor after mounting on the printed circuit board.
 - 1-1. Avoid bending the printed circuit board by the pressure of a test-probe, etc. The thrusting force of the test probe can flex the PCB, resulting in cracked chips or open solder joints. Provide support pins on the back side of the PCB to prevent warping or flexing. Install support pins as close to the test-probe as possible.
 - 1-2. Avoid vibration of the board by shock when a test -probe contacts a printed circuit board.



7. Printed Circuit Board Cropping

- 1. After mounting a capacitor on a printed circuit board, do not apply any stress to the capacitor that caused bending or twisting the board.
 - 1-1. In cropping the board, the stress as shown may cause the capacitor to crack. Cracked capacitors may cause deterioration of the insulation resistance, and result in a short. Avoid this type of stress to a capacitor.



- 2. Check the cropping method for the printed circuit board in advance.
 - 2-1. Printed circuit board cropping shall be carried out by using a jig or an apparatus (Disc separator, router type separator, etc.) to prevent the mechanical stress that can occur to the board.

Board Separation Method	Hand Separation	(1) Board Separation Jig	Board Separation Apparatus		
Board Separation Method	Nipper Separation	(1) Board Separation sig	Disc Separator	3) Router Type Separator	
Level of stress on board	High	Medium	Medium	Low	
Recommended	x	Δ*	Δ*	\circ	
Notes	Hand and nipper separation apply a high level of stress. Use another method.	Board handling Board bending direction Layout of capacitors	Board handling Layout of slits Design of V groove Arrangement of blades Controlling blade life	Board handling	

^{*} When a board separation jig or disc separator is used, if the following precautions are not observed, a large board deflection stress will occur and the capacitors may crack.

Use router type separator if at all possible.

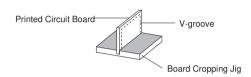
(1) Example of a suitable jig

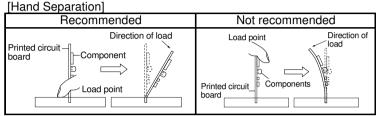
[In the case of Single-side Mounting]

An outline of the board separation jig is shown as follows.

Recommended example: Stress on the component mounting position can be minimized by holding the portion close to the jig, and bend in the direction towards the side where the capacitors are mounted. Not recommended example: The risk of cracks occurring in the capacitors increases due to large stress being applied to the component mounting position, if the portion away from the jig is held and bent in the direction opposite the side where the capacitors are mounted.

[Outline of jig]





[In the case of Double-sided Mounting]

Since components are mounted on both sides of the board, the risk of cracks occurring can not be avoided with the above method. Therefore, implement the following measures to prevent stress from being applied to the components. (Measures)

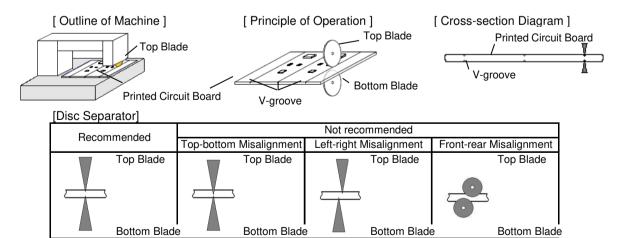
- (1) Consider introducing a router type separator.
 - If it is difficult to introduce a router type separator, implement the following measures. (Refer to item 1. Mounting Position)
- (2) Mount the components parallel to the board separation surface.
- (3) When mounting components near the board separation point, add slits in the separation position near the component.
- (4) Keep the mounting position of the components away from the board separation point.

(2) Example of a Disc Separator

An outline of a disc separator is shown as follows. As shown in the Principle of Operation, the top blade and bottom blade are aligned with the V-grooves on the printed circuit board to separate the board. In the following case, board deflection stress will be applied and cause cracks in the capacitors.

- (1) When the adjustment of the top and bottom blades are misaligned, such as deviating in the top-bottom, left-right or front-rear directions
- (2) The angle of the V groove is too low, depth of the V groove is too shallow, or the V groove is misaligned top-bottom

IF V groove is too deep, it is possible to brake when you handle and carry it. Carefully design depth of the V groove with consideration about strength of material of the printed circuit board.



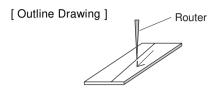
[V-groove Design]				
Example of	Not Recommended			
Recommended	Left-right Misalignment	Low-Angle	Depth too Shallow	Depth too Deep

↑Caution

(3) Example of Router Type Separator

The router type separator performs cutting by a router rotating at a high speed. Since the board does not bend in the cutting process, stress on the board can be suppressed during board separation.

When attaching or removing boards to/from the router type separator, carefully handle the boards to prevent bending.



8. Assembly

1. Handling

If a board mounted with capacitors is held with one hand, the board may bend.

Firmly hold the edges of the board with both hands when handling.

If a board mounted with capacitors is dropped, cracks may occur in the capacitors.

Do not use dropped boards, as there is a possibility that the quality of the capacitors may be impaired.

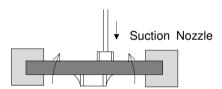
2. Attachment of Other Components

2-1. Mounting of Other Components

Pay attention to the following items, when mounting other components on the back side of the board after capacitors have been mounted on the opposite side.

When the bottom dead point of the suction nozzle is set too low, board deflection stress may be applied to the capacitors on the back side (bottom side), and cracks may occur in the capacitors.

- · After the board is straightened, set the bottom dead point of the nozzle on the upper surface of the board.
- · Periodically check and adjust the bottom dead point.



2-2. Inserting Components with Leads into Boards

When inserting components (transformers, IC, etc.) into boards, bending the board may cause cracks in the capacitors or cracks in the solder. Pay attention to the following.

- · Increase the size of the holes to insert the leads, to reduce the stress on the board during insertion.
- · Fix the board with support pins or a dedicated jig before insertion.
- Support below the board so that the board does not bend. When using multiple support pins on the board, periodically confirm that there is no difference in the height of each support pin.



2-3. Attaching/Removing Sockets

When the board itself is a connector, the board may bend when a socket is attached or removed. Plan the work so that the board does not bend when a socket is attached or removed.



2-4. Tightening Screws

The board may be bent, when tightening screws, etc. during the attachment of the board to a shield or chassis. Pay attention to the following items before performing the work.

- · Plan the work to prevent the board from bending.
- · Use a torque screwdriver, to prevent over-tightening of the screws.
- · The board may bend after mounting by reflow soldering, etc. Please note, as stress may be applied to the chips by forcibly flattening the board when tightening the screws.



Others

1. Under Operation of Equipment

- 1-1. Do not touch a capacitor directly with bare hands during operation in order to avoid the danger of an electric shock.
- 1-2. Do not allow the terminals of a capacitor to come in contact with any conductive objects (short-circuit). Do not expose a capacitor to a conductive liquid, inducing any acid or alkali solutions.
- 1-3. Confirm the environment in which the equipment will operate is under the specified conditions.
 - Do not use the equipment under the following environments.
 - (1) Being spattered with water or oil.
 - (2) Being exposed to direct sunlight.
 - (3) Being exposed to ozone, ultraviolet rays, or radiation.
 - (4) Being exposed to toxic gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
 - (5) Any vibrations or mechanical shocks exceeding the specified limits.
 - (6) Moisture condensing environments.
- 1-4. Use damp proof countermeasures if using under any conditions that can cause condensation.

2. Others

2-1. In an Emergency

- (1) If the equipment should generate smoke, fire, or smell, immediately turn off or unplug the equipment.

 If the equipment is not turned off or unplugged, the hazards may be worsened by supplying continuous power.
- (2) In this type of situation, do not allow face and hands to come in contact with the capacitor or burns may be caused by the capacitor's high temperature.

2-2. Disposal of waste

When capacitors are disposed of, they must be burned or buried by an industrial waste vendor with the appropriate licenses.

2-3. Circuit Design

(1) Addition of Fail Safe Function

Capacitors that are cracked by dropping or bending of the board may cause deterioration of the insulation resistance, and result in a short. If the circuit being used may cause an electrical shock, smoke or fire when a capacitor is shorted, be sure to install fail-safe functions, such as a fuse, to prevent secondary accidents.

(2) This series are not safety standard certified products.

2-4. Remarks

Failure to follow the cautions may result, worst case, in a short circuit and smoking when the product is used. The above notices are for standard applications and conditions. Contact us when the products are used in special mounting conditions.

Select optimum conditions for operation as they determine the reliability of the product after assembly. The data herein are given in typical values, not guaranteed ratings.

Rating

1.Operating Temperature

- 1. The operating temperature limit depends on the capacitor.
- 1-1. Do not apply temperatures exceeding the maximum operating temperature.

 It is necessary to select a capacitor with a suitable rated temperature that will cover the operating temperature range.

 It is also necessary to consider the temperature distribution in equipment and the seasonal temperature variable factor.
- 1-2. Consider the self-heating factor of the capacitor

 The surface temperature of the capacitor shall not exceed the maximum operating temperature including self-heating.

2.Atmosphere Surroundings (gaseous and liquid)

- 1. Restriction on the operating environment of capacitors.
- 1-1. Capacitors, when used in the above, unsuitable, operating environments may deteriorate due to the corrosion of the terminations and the penetration of moisture into the capacitor.
- 1-2. The same phenomenon as the above may occur when the electrodes or terminals of the capacitor are subject to moisture condensation.
- 1-3. The deterioration of characteristics and insulation resistance due to the oxidization or corrosion of terminal electrodes may result in breakdown when the capacitor is exposed to corrosive or volatile gases or solvents for long periods of time.

3.Piezo-electric Phenomenon

 When using high dielectric constant type capacitors in AC or pulse circuits, the capacitor itself vibrates at specific frequencies and noise may be generated.
 Moreover, when the mechanical vibration or shock is added to capacitor, noise may occur.

■Soldering and Mounting

1.PCB Design

- 1. Notice for Pattern Forms
- 1-1. Unlike leaded components, chip components are susceptible to flexing stresses since they are mounted directly on the substrate.
 - They are also more sensitive to mechanical and thermal stresses than leaded components.
 - Excess solder fillet height can multiply these stresses and cause chip cracking.
 - When designing substrates, take land patterns and dimensions into consideration to eliminate the possibility of excess solder fillet height.
- 1-2. There is a possibility of chip cracking caused by PCB expansion/contraction with heat, because stress on a chip is different depending on PCB material and structure. When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction. When capacitors are mounted on a fluorine resin printed circuit board or on a single-layered glass epoxy board, it may also cause cracking of the chip for the same reason.

Pattern Forms Prohibited Correct Chassis Solder Resist Solder (ground) Placing Close to Chassis Electrode Pattern in section in section Lead Wire Solder Resist Placing of Chip Components and Leaded Components in section in section Soldering Iron Lead Wire Placing of Leaded Solder Resist Components after Chip Component in section in section Solder Resist ソルダ レジ スト Lateral Mounting